

Search Notes

Application/Control No.

10/733,927

Examiner

Khawar Iqbal

Applicant(s)/Patent under
Reexamination

JEONG ET AL.

Art Unit

2686

SEARCHED

Class	Subclass	Date	Examiner
455	450	8-26-5	(Jen)
	403		
	432.1		
	435.1		
	436		
	437		
	440		
	441		
	446		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner